# onsemi

# **MOSFET** – Power, Single, N-Channel

80	V,	2.8	mΩ,	157	A
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# NVMFS6H801N

#### Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6H801NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	80	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V	
Continuous Drain	Steady State	$T_C = 25^{\circ}C$	I <sub>D</sub>	157	А	
Current R <sub>θJC</sub> (Notes 1, 3)	Sidle	T <sub>C</sub> = 100°C		111		
Power Dissipation		T <sub>C</sub> = 25°C	PD	166	W	
$R_{\theta JC}$ (Note 1)		$T_{C} = 100^{\circ}C$		83		
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	23	А	
Current R <sub>θJA</sub> (Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		16		
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.8	W	
$R_{\theta JA}$ (Notes 1, 2)		$T_A = 100^{\circ}C$		1.9		
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	А	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C		
Source Current (Body Diode)		۱ <sub>S</sub>	138	А		
Single Pulse Drain-to-S Energy (I <sub>L(pk)</sub> = 12.2 A)	Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 12.2 A)		E <sub>AS</sub>	960	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

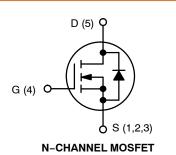
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	2.8 mΩ @ 10 V	157 A

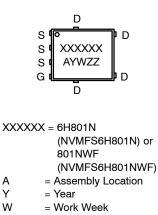




DFN5 (SO-8FL) CASE 488AA STYLE 1

DFNW5 (FULL-CUT SO8FL WF) CASE 507BA

#### MARKING DIAGRAM



ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

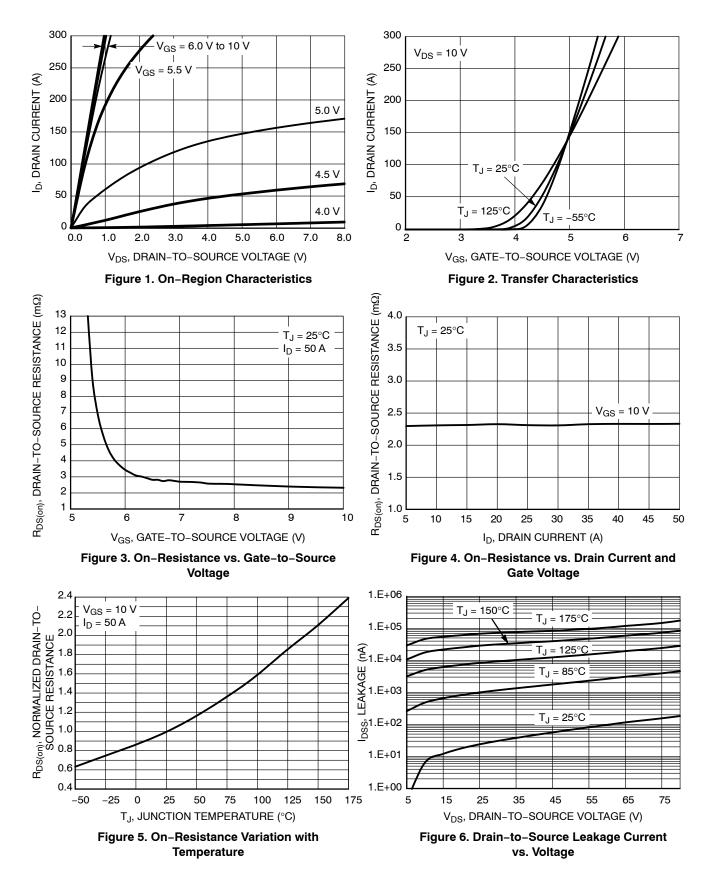
#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		-		-			
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				38		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	T <sub>J</sub> = 25 °C			10	μA
		V <sub>DS</sub> = 80 V	T <sub>J</sub> = 125°C		100		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS}$ = $V_{DS}$ , $I_D$ = 250 $\mu$	A	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		2.3	2.8	mΩ
Forward Transconductance	9fs	V <sub>DS</sub> =15 V, I <sub>D</sub> = 50 A			128		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE			-	-		
Input Capacitance	C <sub>ISS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 40 V			4120		pF
Output Capacitance	C <sub>OSS</sub>				586		
Reverse Transfer Capacitance	C <sub>RSS</sub>			22			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A			64		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 40	V; I <sub>D</sub> = 50 A		11		1
Gate-to-Source Charge	Q <sub>GS</sub>	-			19		1
Gate-to-Drain Charge	Q <sub>GD</sub>				13		
Plateau Voltage	V <sub>GP</sub>				5.0		V
SWITCHING CHARACTERISTICS (Note 5	)			-	-		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 64$	V,		25		ns
Rise Time	tr	I <sub>D</sub> = 50 A, R <sub>G</sub> = 2.5 Ω			74		1
Turn–Off Delay Time	t <sub>d(OFF)</sub>				70		]
Fall Time	t <sub>f</sub>				19		
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.8	1.2	V
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.7		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 50 A			64		ns
Charge Time	ta				36		
Discharge Time	t <sub>b</sub>				28		1
Reverse Recovery Charge	Q <sub>RR</sub>				98		nC

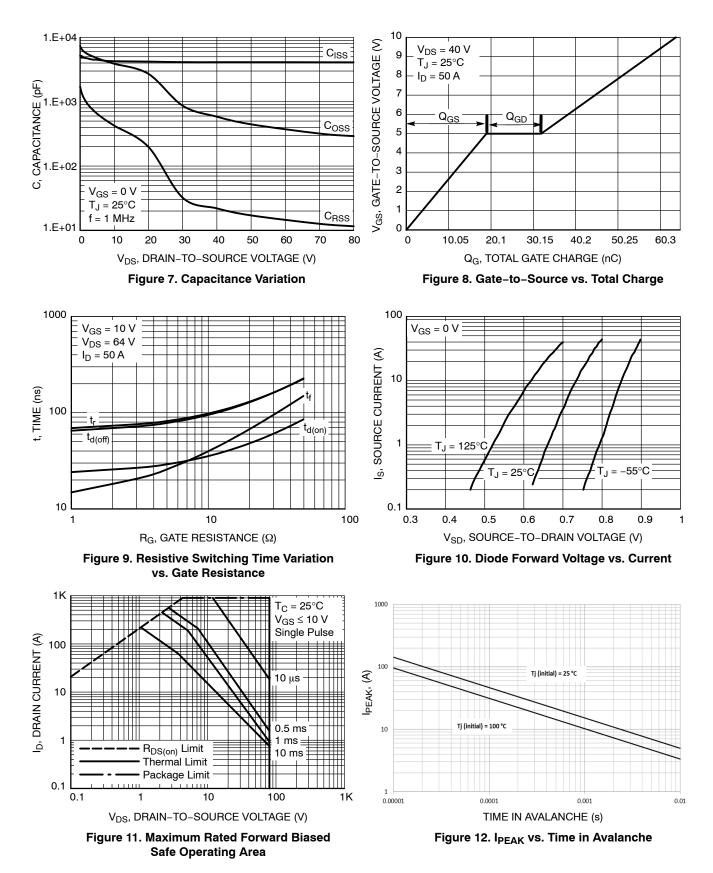
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

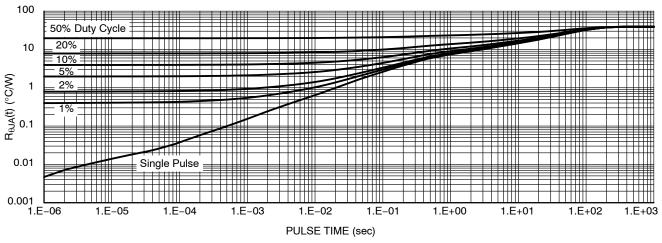
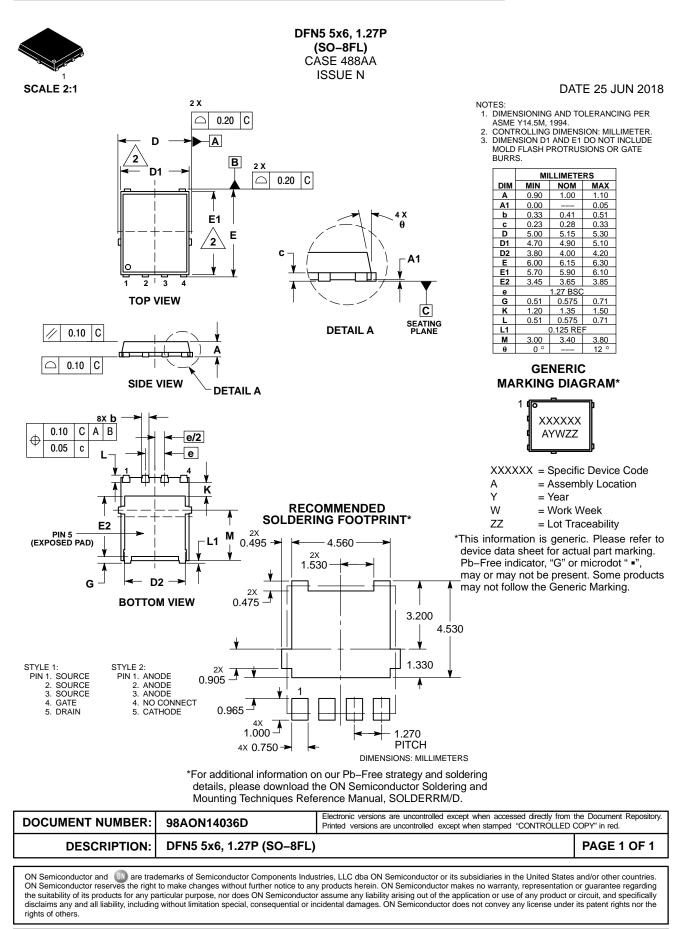


Figure 13. Thermal Characteristics

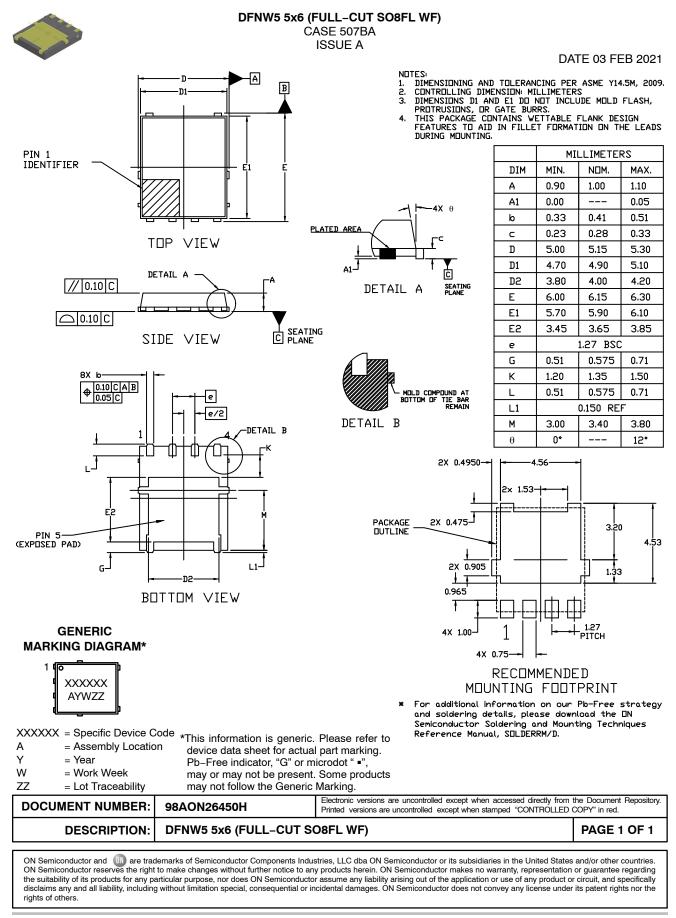
Device	Marking	Package	Shipping <sup>†</sup>
NVMFS6H801NT1G	6H801N	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS6H801NT3G	6H801N	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS6H801NWFT1G	801NWF	DFNW5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS6H801NWFT3G	801NWF	DFNW5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.









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